

Notice of References Cited	Application/Control No. 10/761,361		Applicant(s)/Patent Under Reexamination OGAWA ET AL.	
	Examiner TAN X. DINH		Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,567,372 b2	05-2003	Takamine et al.	369/275.4
*	B	US-6,268,034 b1	07-2001	Kitaura et al.	428/64.1
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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